

X-ray Diffraction and Crystal Structures

November 25, 2014

PHYS 4580, PHYS 6/7280

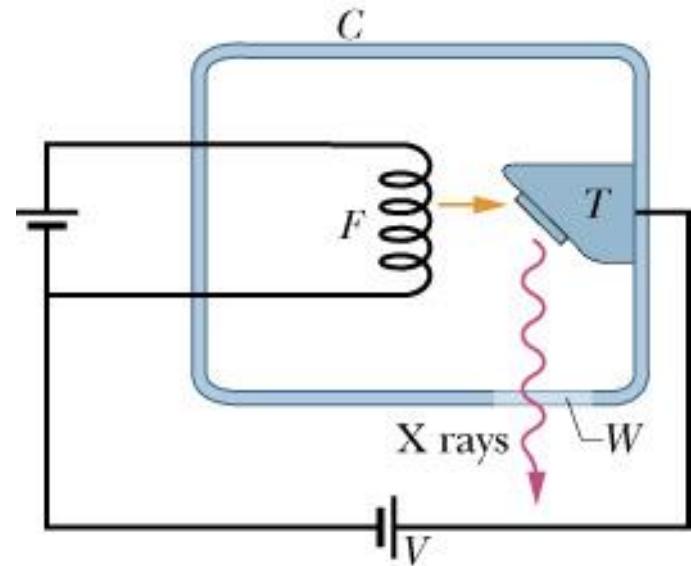
The University of Toledo
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X-Ray Generation

X-rays are electromagnetic radiation with wavelength $\sim 1 \text{ \AA} = 10^{-10} \text{ m}$ (visible light $\sim 5.5 \times 10^{-7} \text{ m}$)

X-ray generation: electrons are emitted from the cathode and accelerated toward the anode. Here, Bremsstrahlung radiation occurs as a result of the “braking” process – X-ray photons are emitted.



X-ray wavelengths too short to be resolved by a standard optical grating

$$q = \sin^{-1} \frac{m}{d} = \sin^{-1} \frac{(1)(0.1 \text{ nm})}{3000 \text{ nm}} = 0.0019^\circ$$

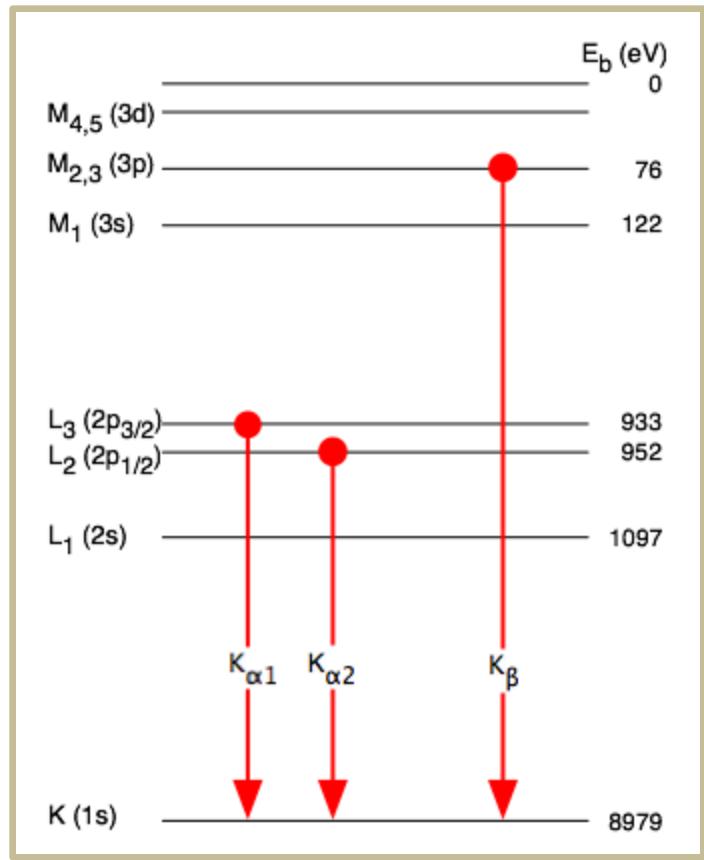
X-Ray Generation

The most common metal used is copper, which can be kept cool easily, due to its high thermal conductivity, and which produces strong K_{α} and K_{β} lines. The K_{β} line is sometimes suppressed with a thin ($\sim 10 \mu\text{m}$) nickel foil.

- **K-alpha (K_{α})** emission lines result when an electron transitions to the innermost "K" shell (principal quantum number 1) from a 2p orbital of the second or "L" shell (with principal quantum number 2).
- The K_{α} line is actually a doublet, with slightly different energies depending on spin-orbit interaction energy between the electron spin and the orbital momentum of the 2p orbital.

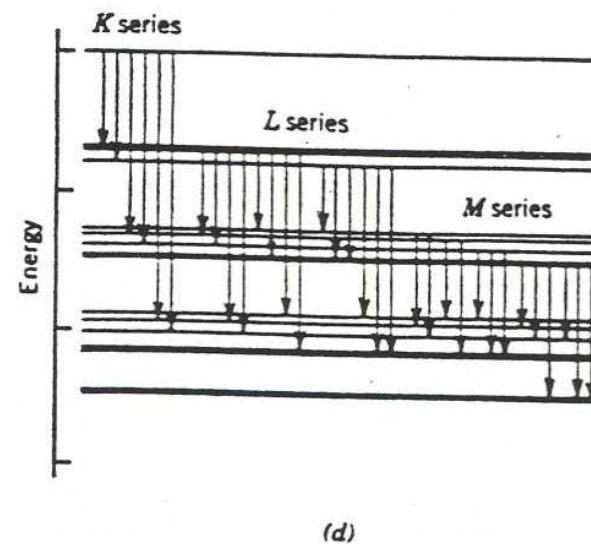
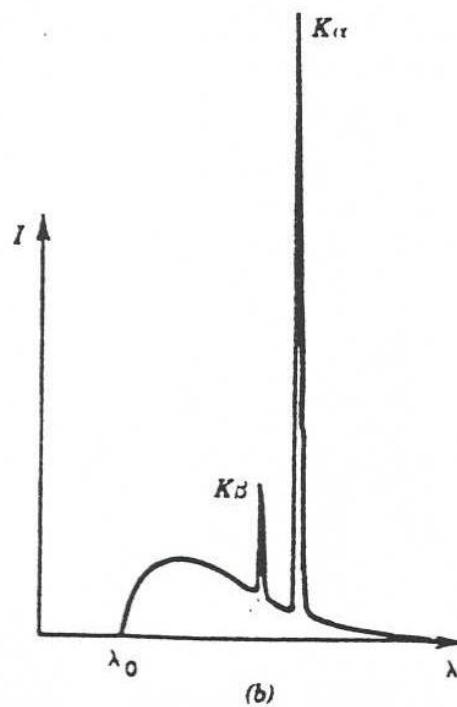
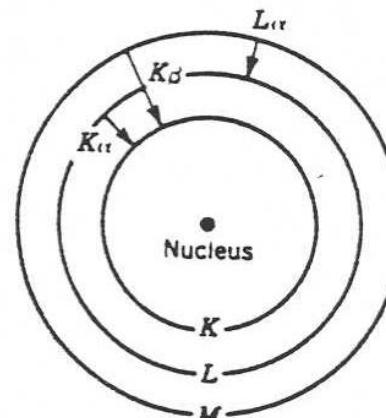
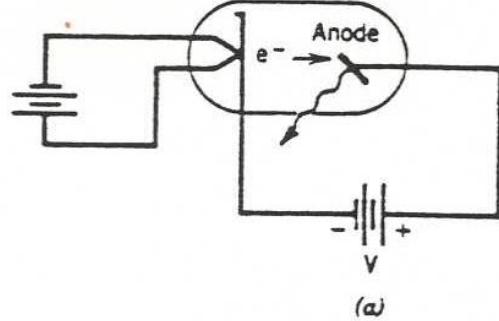
$$\lambda(K_{\alpha 2}) = 0.154 \text{ nm}$$

$$\lambda(K_{\alpha 1}) = 0.139 \text{ nm}$$



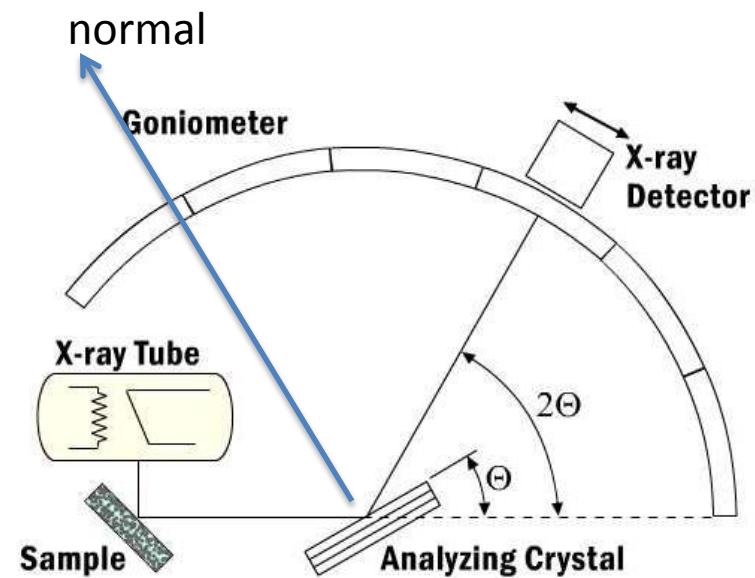
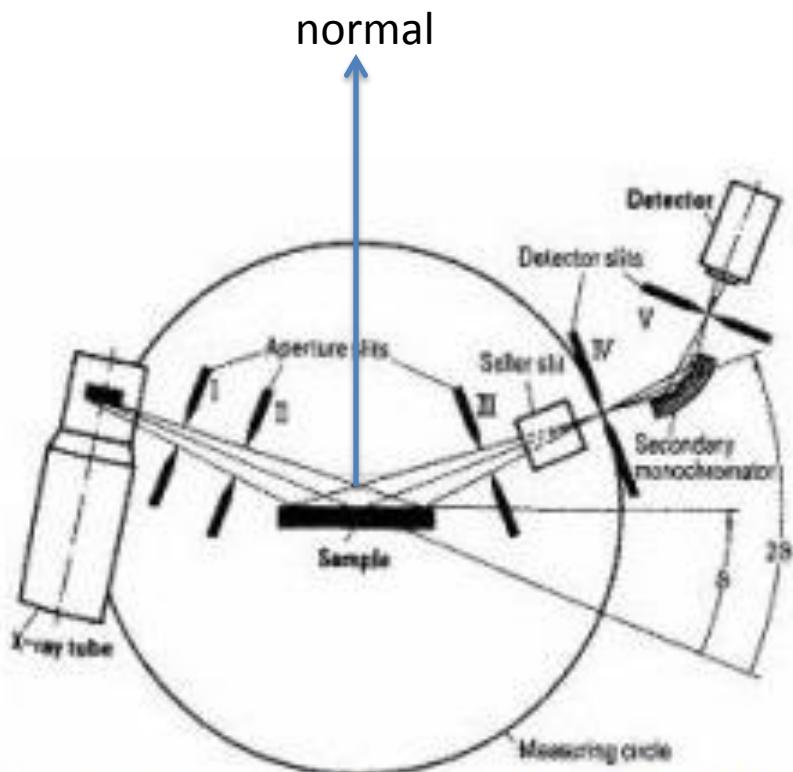
Atomic levels involved in copper K_{α} and K_{β} emission.

K_{α} and K_{β} X-ray lines



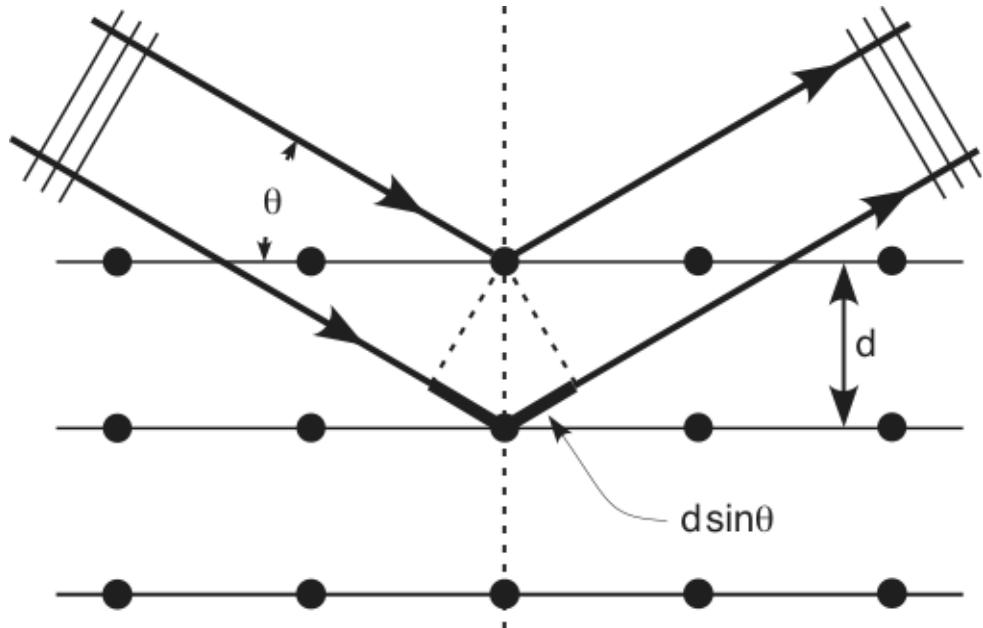
K_I
 L_I
 L_{II}
 L_{III}
 M_I
 M_{II}
 M_{III}
 M_{IV}
 M_V
 N_I
 N_{II}
 N_{III}
 N_{IV}
 N_V
 N_{VI}
 N_{VII}

Diffractometer Designs

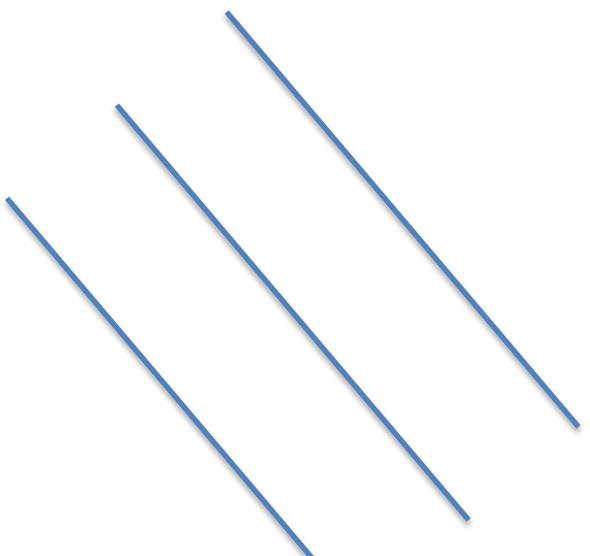


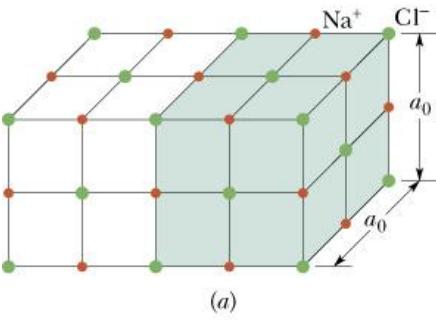
Schematic of an X-ray diffractometer of
bragg-bretano para-focusing
diffractometer

X-Ray diffraction

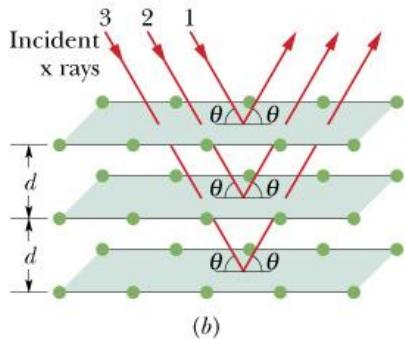


Crystallites may not be properly oriented to diffract





X-Ray Diffraction -- Bragg's Law



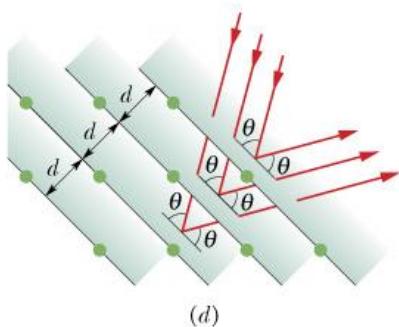
Diffraction of x-rays by crystal: spacing d of adjacent crystal planes on the order of 0.1 nm

→ three-dimensional diffraction grating with diffraction maxima along angles where reflections from different planes interfere constructively

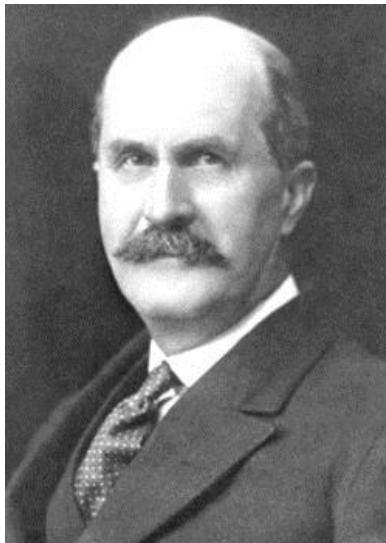
$$2d \sin \theta = m\lambda \text{ for } m = 0, 1, 2, \dots$$

Bragg's Law

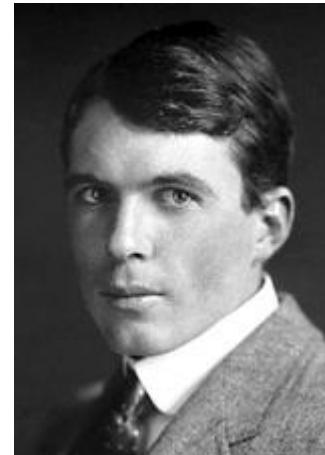
Note that your measured XRD spectra will most likely reveal only 1st order diffracted lines (i.e., those for which $m = 1$).



The Braggs (Bragg's Law)



Sir William Henry Bragg
1862-1942

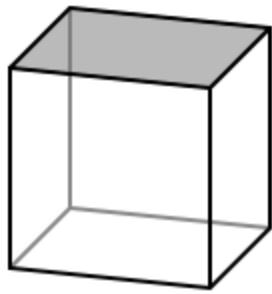


William Lawrence Bragg
1890-1971

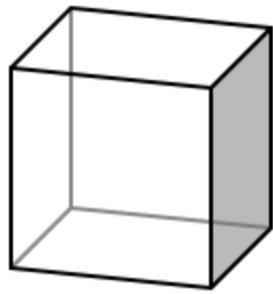
Bragg occupied the Cavendish chair of physics at the University of Leeds from 1909. He continued his work on X-rays with much success. He invented the X-ray spectrometer and with his son, William Lawrence Bragg, then a research student at Cambridge, founded the new science of X-ray analysis of crystal structure.

In 1915 father and son were jointly awarded the Nobel Prize in Physics for their studies, using the X-ray spectrometer, of X-ray spectra, X-ray diffraction, and of crystal structure.

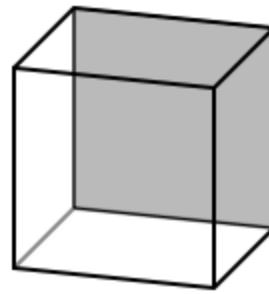
Crystal structure and Miller indices



(001)

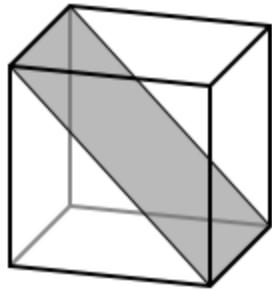


(100)

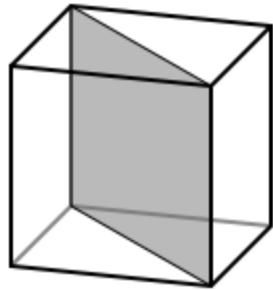


(010)

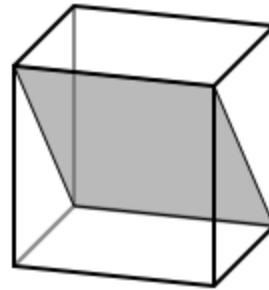
Planes with different Miller indices in cubic crystals.



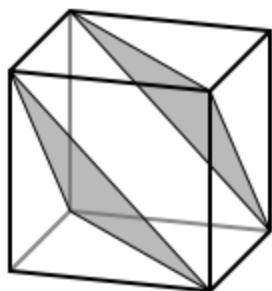
(101)



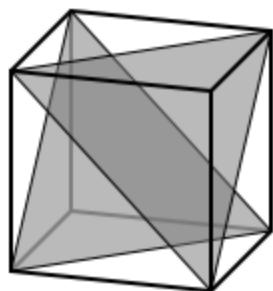
(110)



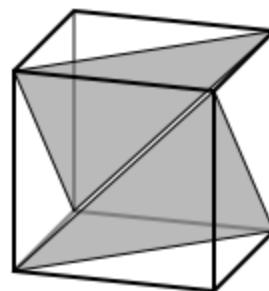
(011)



(111)



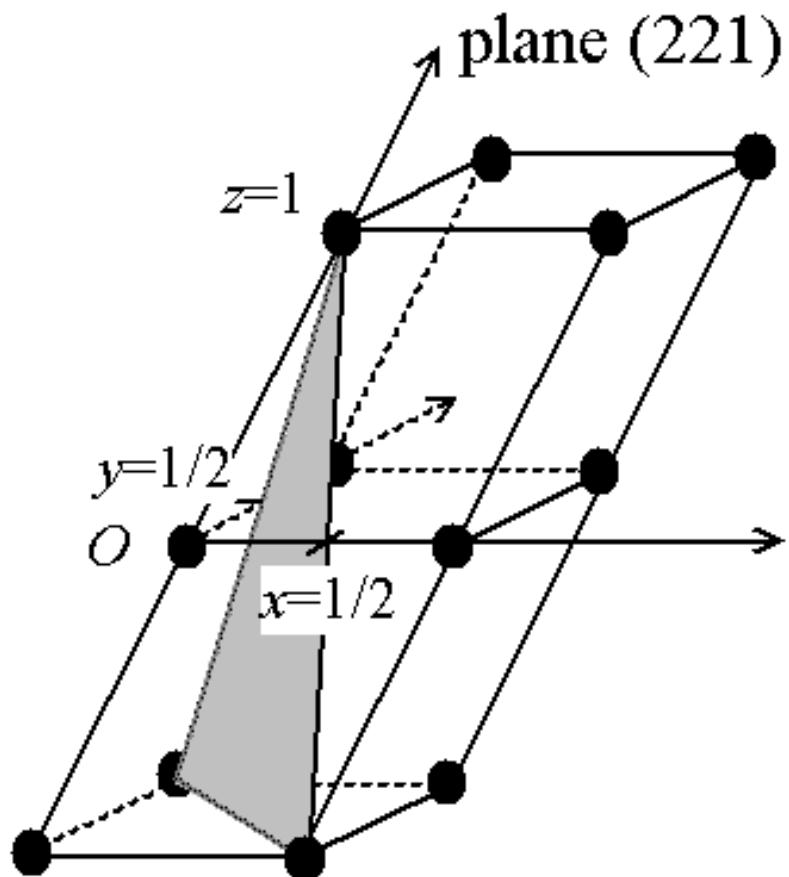
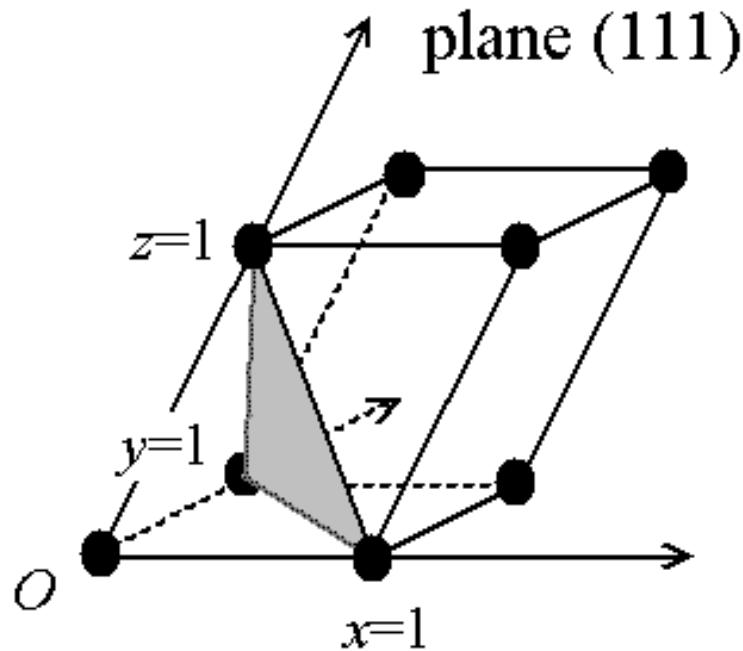
(1-11)



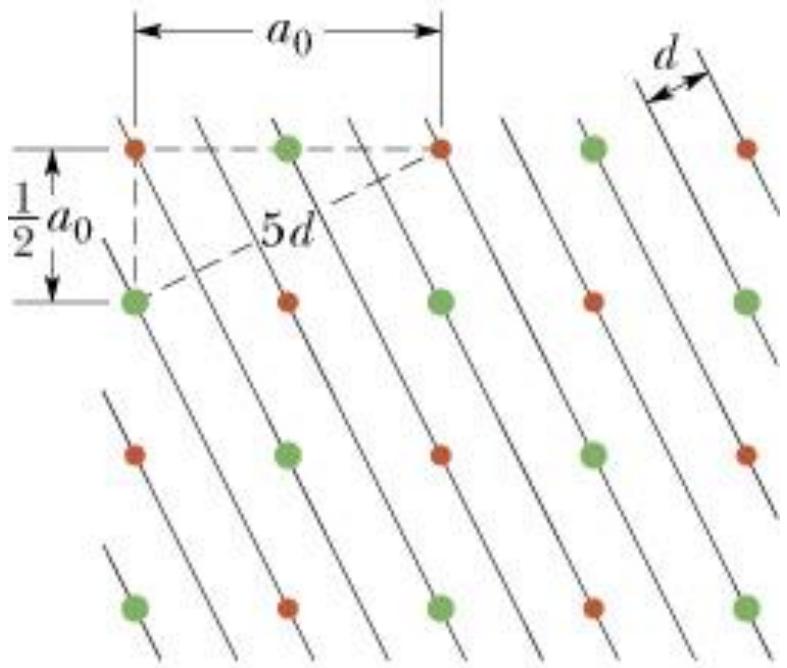
(-111)

Crystal structure, lattice planes, and Miller indices

Planes with different Miller indices in cubic crystals. The *inverse* of these fractional intercepts yields the Miller indices h, k, l .



Any set of parallel planes can lead to diffraction

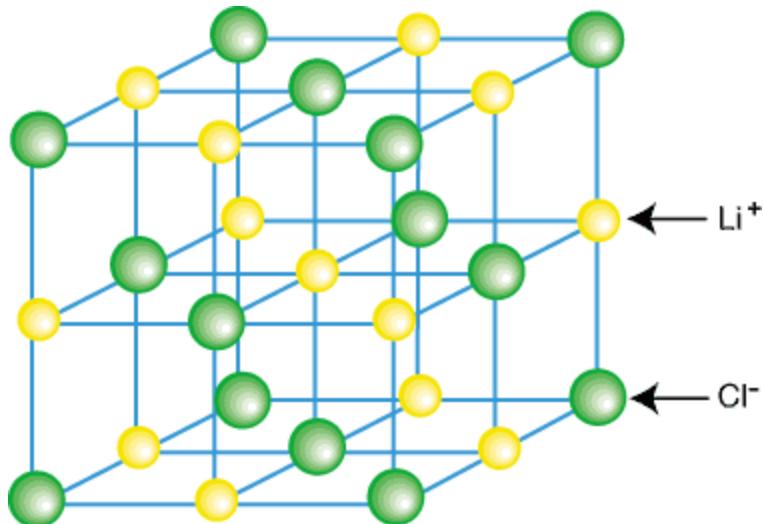


Interplanar spacing d is related to the unit cell dimension a_0

$$5d = \sqrt{\frac{5}{4} a_0^2} \quad \text{or} \quad d = \frac{a_0}{20} = 0.2236a_0$$

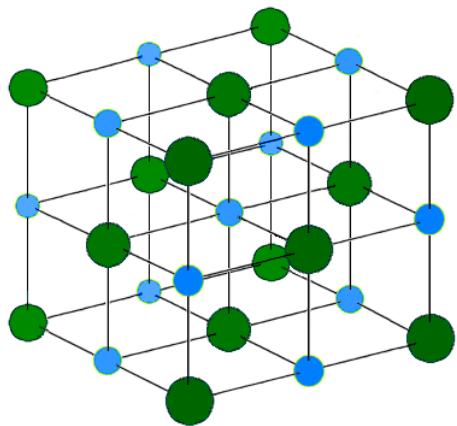
Not only can crystals be used to separate different x-ray wavelengths, but x-rays in turn can be used to study crystals, for example determine the type of crystal ordering and a_0 .

Crystal structure and Miller indices



Indexing lattice planes

Rock salt (cubic) crystal structure



$$d_{hkl} = \frac{a_0}{\sqrt{h^2 + k^2 + l^2}}$$

Structure factor for NaCl:

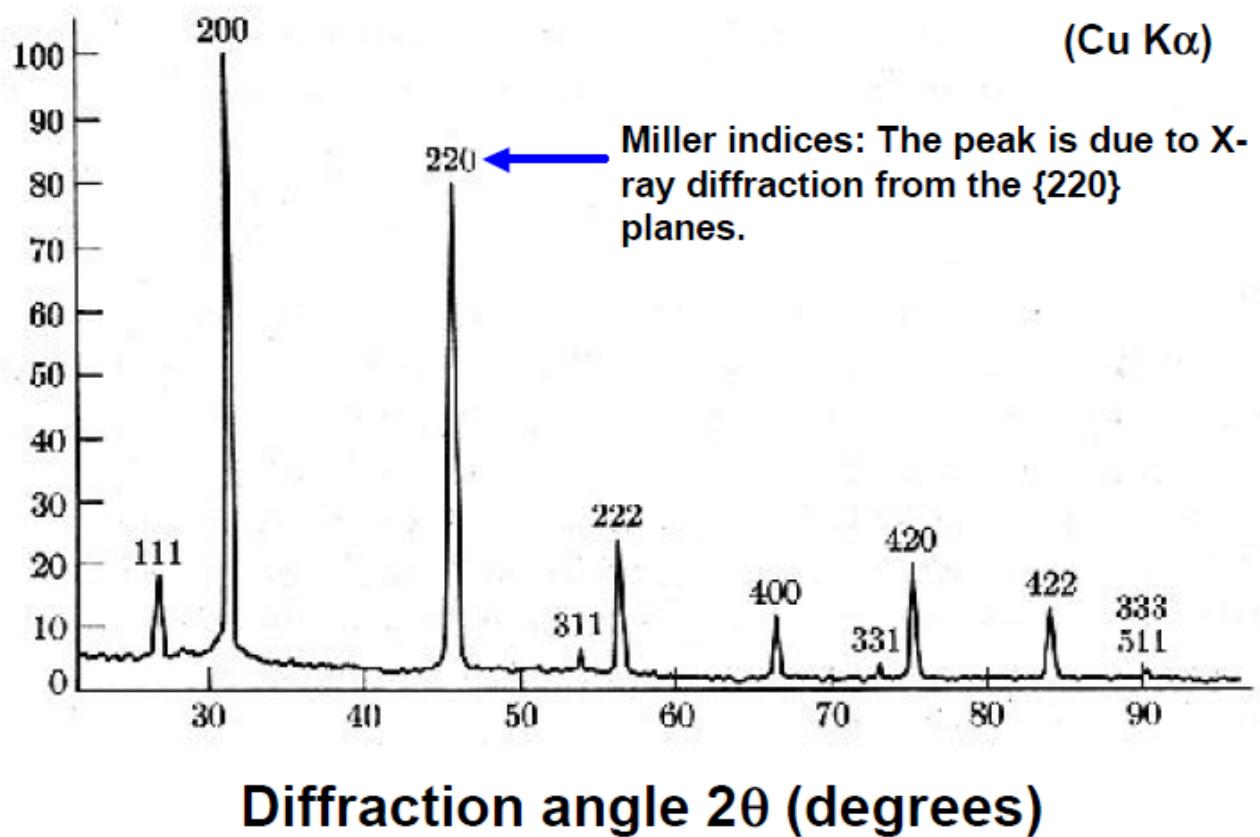
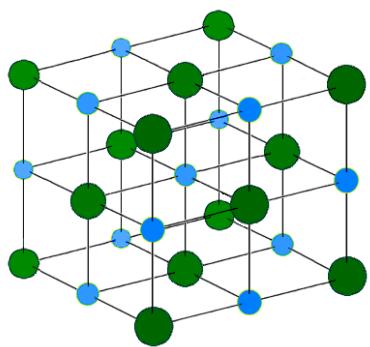
$$F = [f_{Na} + f_{Cl} e^{i\pi(h+k+l)} [1 + e^{i\pi(h+k)} + e^{i\pi(h+l)} + e^{i\pi(k+l)}]$$

$$F = 4(f_{Na} + f_{Cl}) \quad \text{if } h, k, l \text{ are even}$$

$$F = 4(f_{Na} - f_{Cl}) \quad \text{if } h, k, l \text{ are odd}$$

$$F = 0 \quad \text{if } h, k, l \text{ are mixed}$$

X-Ray diffraction (XRD) pattern (diffractogram) from NaCl



$$d_{hkl} = \frac{a_0}{\sqrt{h^2 + k^2 + l^2}}$$

The value of d , the distance between adjacent planes in the set (hkl) , may be found from the following equations.

$$\text{Cubic: } \frac{1}{d^2} = \frac{h^2 + k^2 + l^2}{a^2}$$

$$\text{Tetragonal: } \frac{1}{d^2} = \frac{h^2 + k^2}{a^2} + \frac{l^2}{c^2}$$

$$\text{Hexagonal: } \frac{1}{d^2} = \frac{4}{3} \left(\frac{h^2 + hk + k^2}{a^2} \right) + \frac{l^2}{c^2}$$

Rhombohedral:

$$\frac{1}{d^2} = \frac{(h^2 + k^2 + l^2) \sin^2 \alpha + 2(hk + kl + hl)(\cos^2 \alpha - \cos \alpha)}{a^2(1 - 3 \cos^2 \alpha + 2 \cos^3 \alpha)}$$

$$\text{Orthorhombic: } \frac{1}{d^2} = \frac{h^2}{a^2} + \frac{k^2}{b^2} + \frac{l^2}{c^2}$$

$$\text{Monoclinic: } \frac{1}{d^2} = \frac{1}{\sin^2 \beta} \left(\frac{h^2}{a^2} + \frac{k^2 \sin^2 \beta}{b^2} + \frac{l^2}{c^2} - \frac{2hl \cos \beta}{ac} \right)$$

$$\text{Triclinic: } \frac{1}{d^2} = \frac{1}{V^2} (S_{11}h^2 + S_{22}k^2 + S_{33}l^2 + 2S_{12}hk + 2S_{23}kl + 2S_{13}hl)$$

In the equation for triclinic crystals,

V = volume of unit cell

$$S_{11} = b^2 c^2 \sin^2 \alpha,$$

$$S_{22} = a^2 c^2 \sin^2 \beta,$$

$$S_{33} = a^2 b^2 \sin^2 \gamma,$$

$$S_{12} = abc^2(\cos \alpha \cos \beta - \cos \gamma),$$

$$S_{23} = a^2 bc(\cos \beta \cos \gamma - \cos \alpha),$$

$$S_{13} = ab^2 c(\cos \gamma \cos \alpha - \cos \beta).$$

d spacings for tetragonal, hexagonal, orthorhombic crystals

Bragg's Law (1):

$$d = \frac{\lambda}{2 \sin \theta_c} \quad (1)$$

$$d_{hkl} = \frac{a}{\sqrt{h^2 + k^2 + l^2}} \quad (2) \text{ Plane spacing for cubic crystals}$$

Combined (1) and (2):

$$\left(\frac{n\lambda}{2a}\right)^2 = \frac{\sin^2 \theta}{h^2 + k^2 + l^2} \text{ or } \sin^2 \theta = \frac{\lambda^2}{4a^2} (h^2 + k^2 + l^2) \quad (3)$$

For a particular incident x-ray wavelength and cubic crystal of unit cell size a , this equation predicts all possible Bragg angles at which diffraction can occur from planes (hkl).

→ Diffraction planes are determined solely by the shape and size (lattice parameters) of the unit cell.

Plane spacings for:

Tetragonal:

$$\frac{1}{d^2} = \frac{h^2 + k^2}{a^2} + \frac{l^2}{c^2} \quad (4)$$

Hexagonal:

$$\frac{1}{d^2} = \frac{4}{3} \left(\frac{h^2 + hk + k^2}{a^2} \right) + \frac{l^2}{c^2} \quad (5)$$

Orthorhombic:

$$\frac{1}{d^2} = \frac{h^2}{a^2} + \frac{k^2}{b^2} + \frac{l^2}{c^2} \quad (6)$$

If crystal is tetragonal with $a=a \neq c$ then (1) and (4) become:

$$\sin^2 \theta = \frac{\lambda^2}{4a^2} (h^2 + k^2) + \frac{\lambda^2}{4c^2} (l^2) \quad (7)$$

If crystal is hexagonal with $a=a \neq c$ then (1) and (5) become:

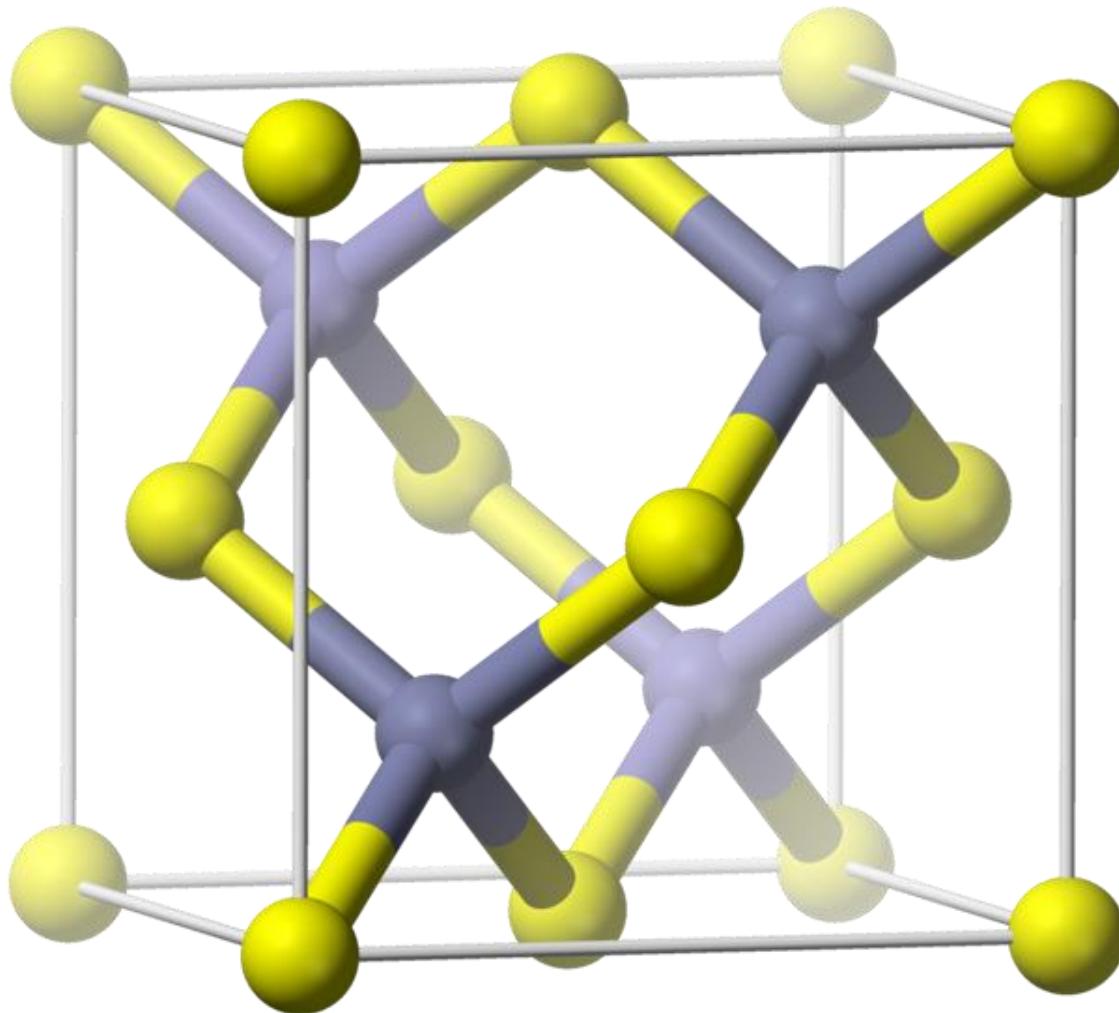
$$\sin^2 \theta = \frac{\lambda^2}{3a^2} (h^2 + k^2 + hk) + \frac{\lambda^2}{4c^2} (l^2) \quad (8)$$

If crystal is orthorhombic with $a \neq b \neq c$ then (1) and (6):

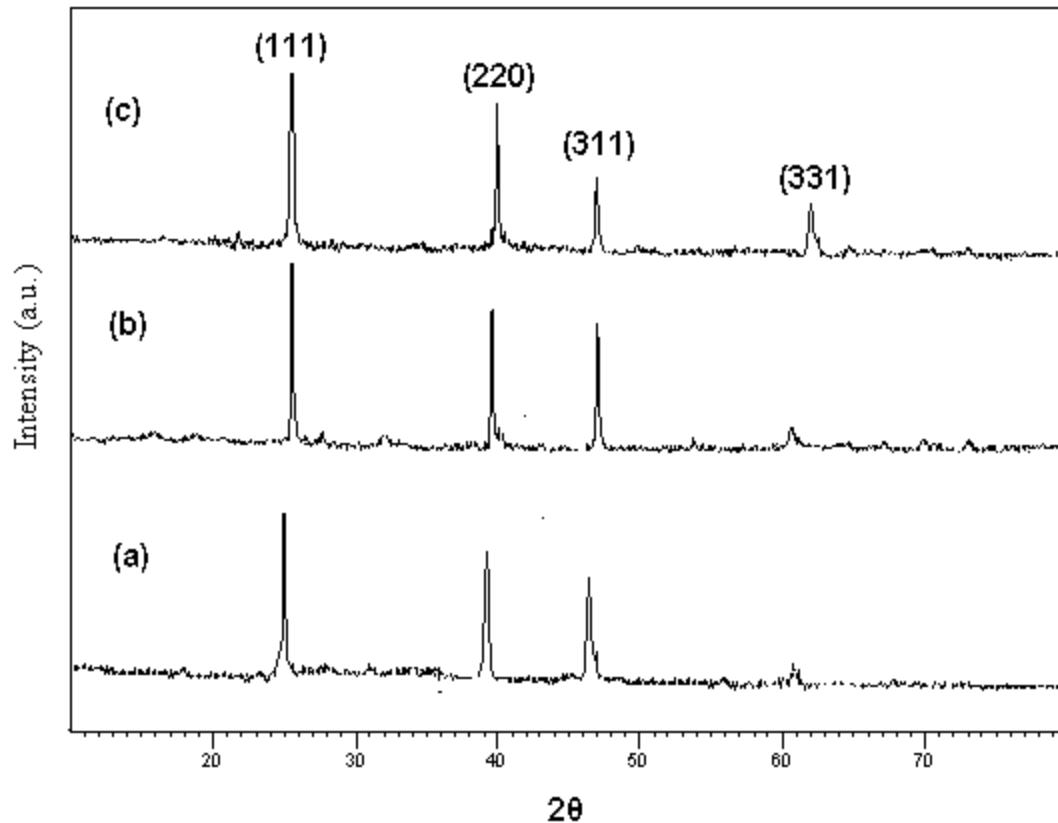
$$\sin^2 \theta = \frac{\lambda^2}{4a^2} (h^2) + \frac{\lambda^2}{4b^2} (k^2) + \frac{\lambda^2}{4c^2} (l^2) \quad (9)$$

CdTe crystal structure (zincblende)

$a_0 = 0.648 \text{ nm}$

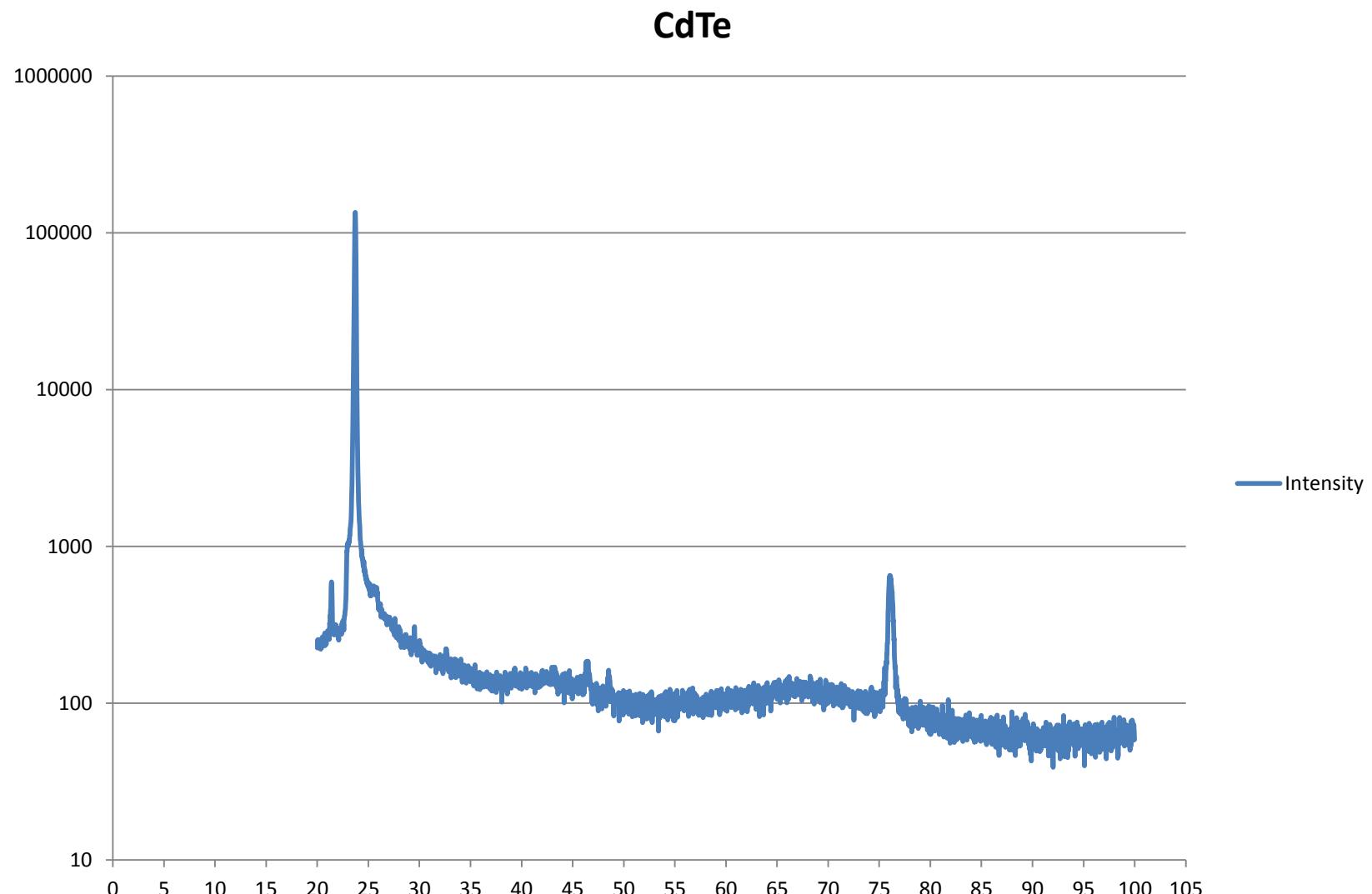


CdTe XRD pattern



X-ray diffractograms of thin films at annealing temperatures of a) 350 C, b) 400 C and c) 450 C.

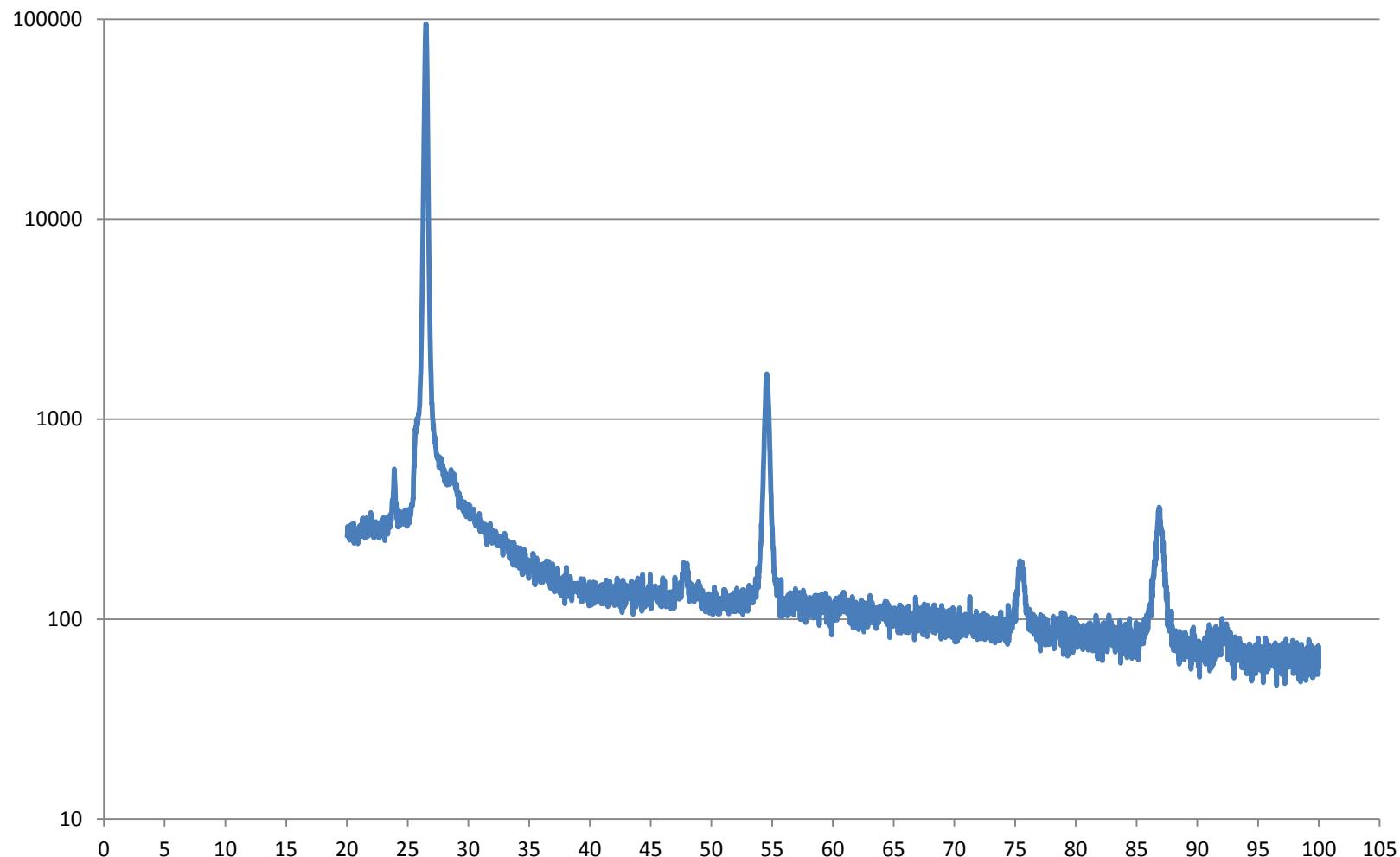
CdTe XRD pattern (intensity vs. 2θ)



CdS XRD pattern (intensity vs. 2θ)

$a_0 = 0.5832 \text{ nm}$ for zincblende
 $a=4.160$; $c=6.756$ for wurtzite

CdS



Scherrer Equation (relationship to Shape Factor)

$$\tau = \frac{K\lambda}{\beta \cos \theta}$$

K is the shape factor, λ is the x-ray wavelength used for the measurement, β is the line width (FWHM) in radians, θ is the Bragg angle (note, this is not the 2θ angle, just θ), and τ is the mean size of the crystalline domains. The formula yields a lower bound on the possible particle size.

The shape factor enables one to determine the average size of crystal grains within a polycrystalline thin film. Assuming a Gaussian function to fit the peak, the shape factor is 0.9, so that

$$\tau = \frac{0.9\lambda}{\beta \cos \theta}$$

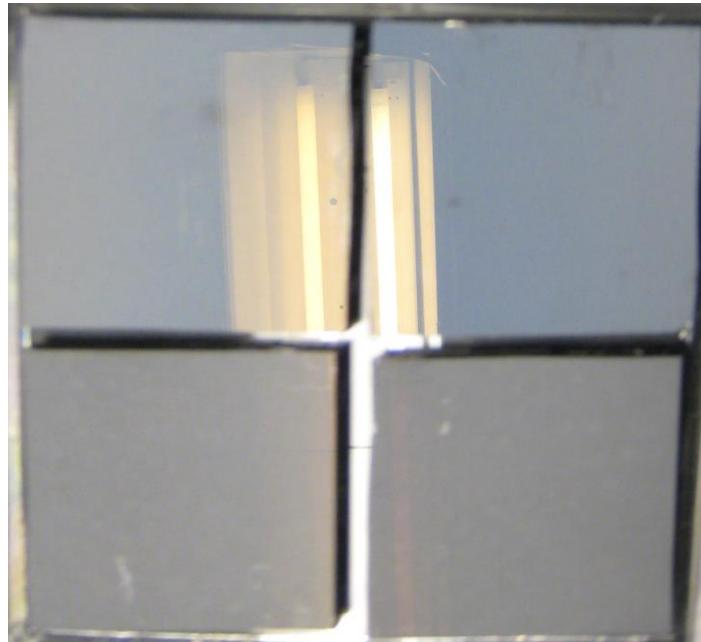


CdTe XRD

Meghan Mapes

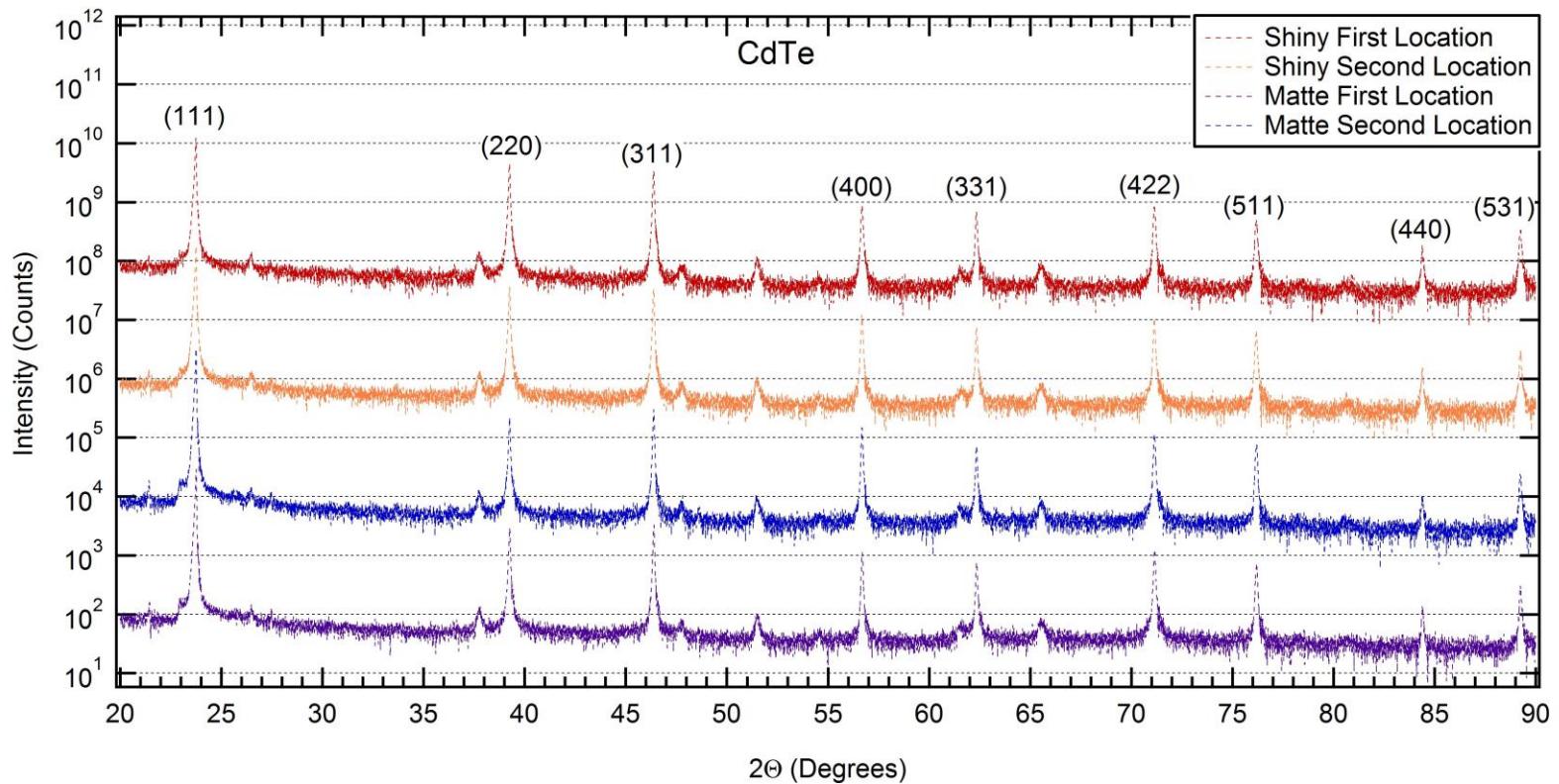
February 6, 2012

Motivation



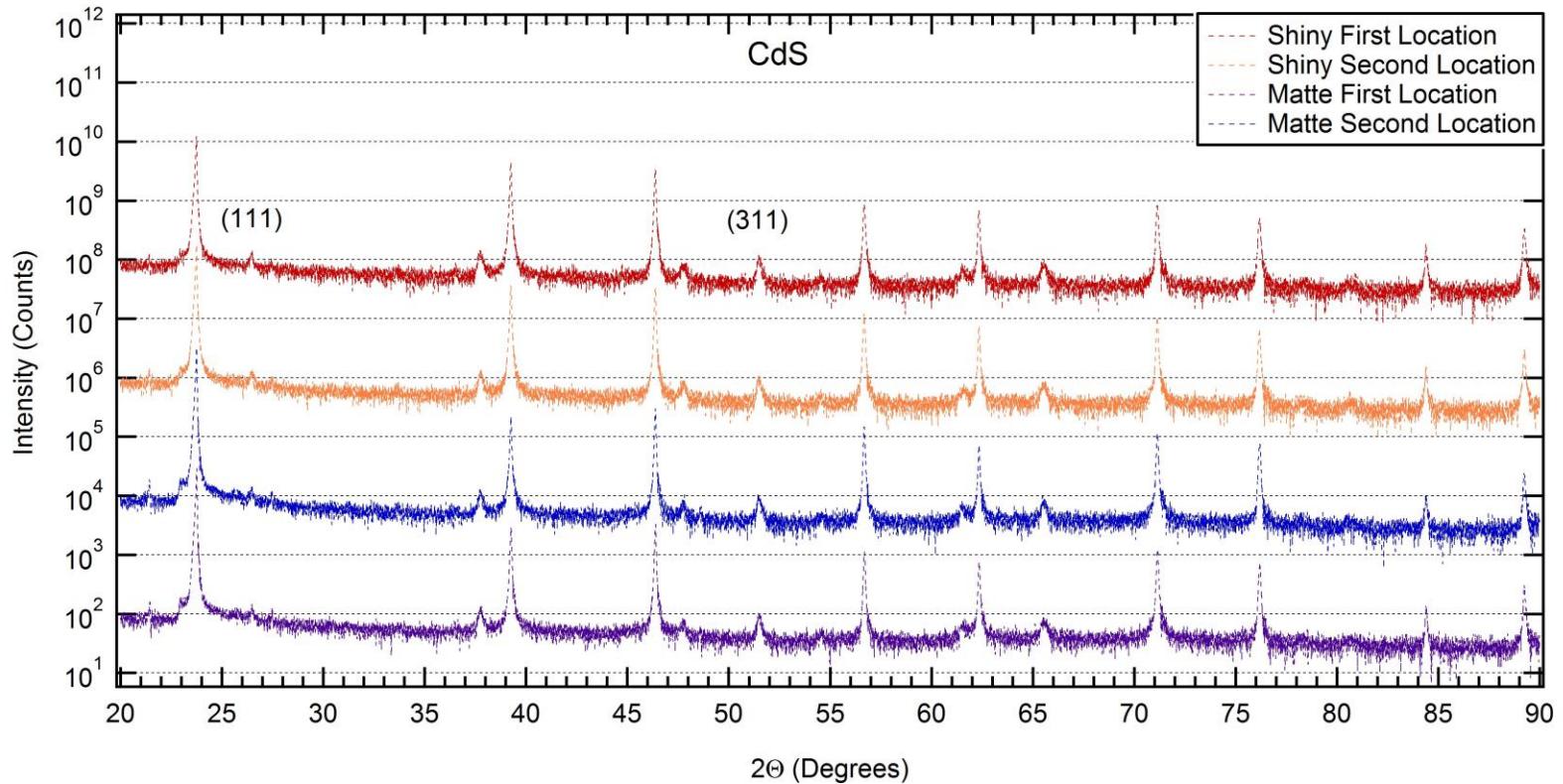
Determine why some samples appear shiny, and some appear matte.

Raw Data



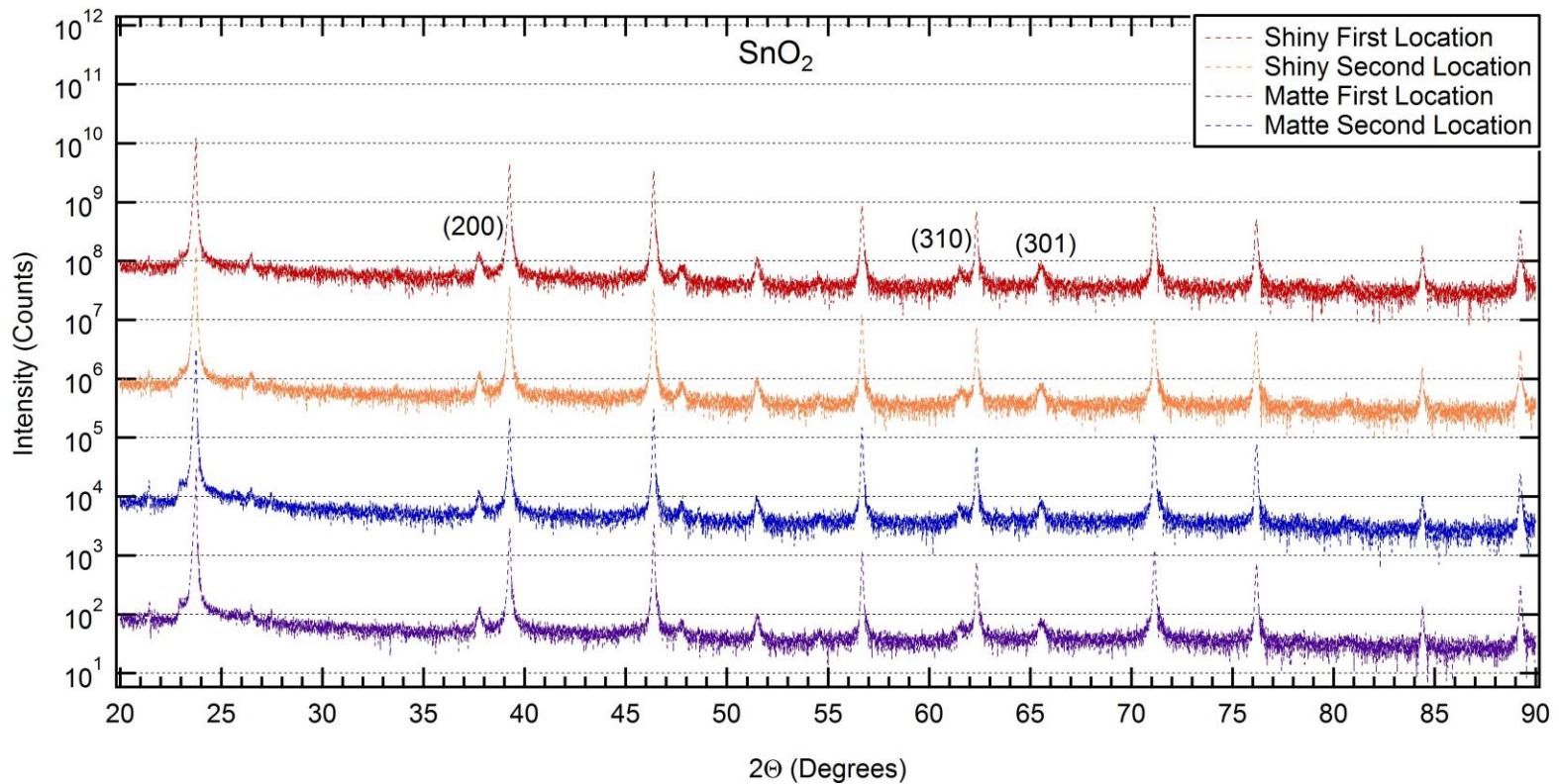
Peaks were considered if they were known CdTe peaks. Peaks from other layers (ex. CdS) were not included.

Raw Data



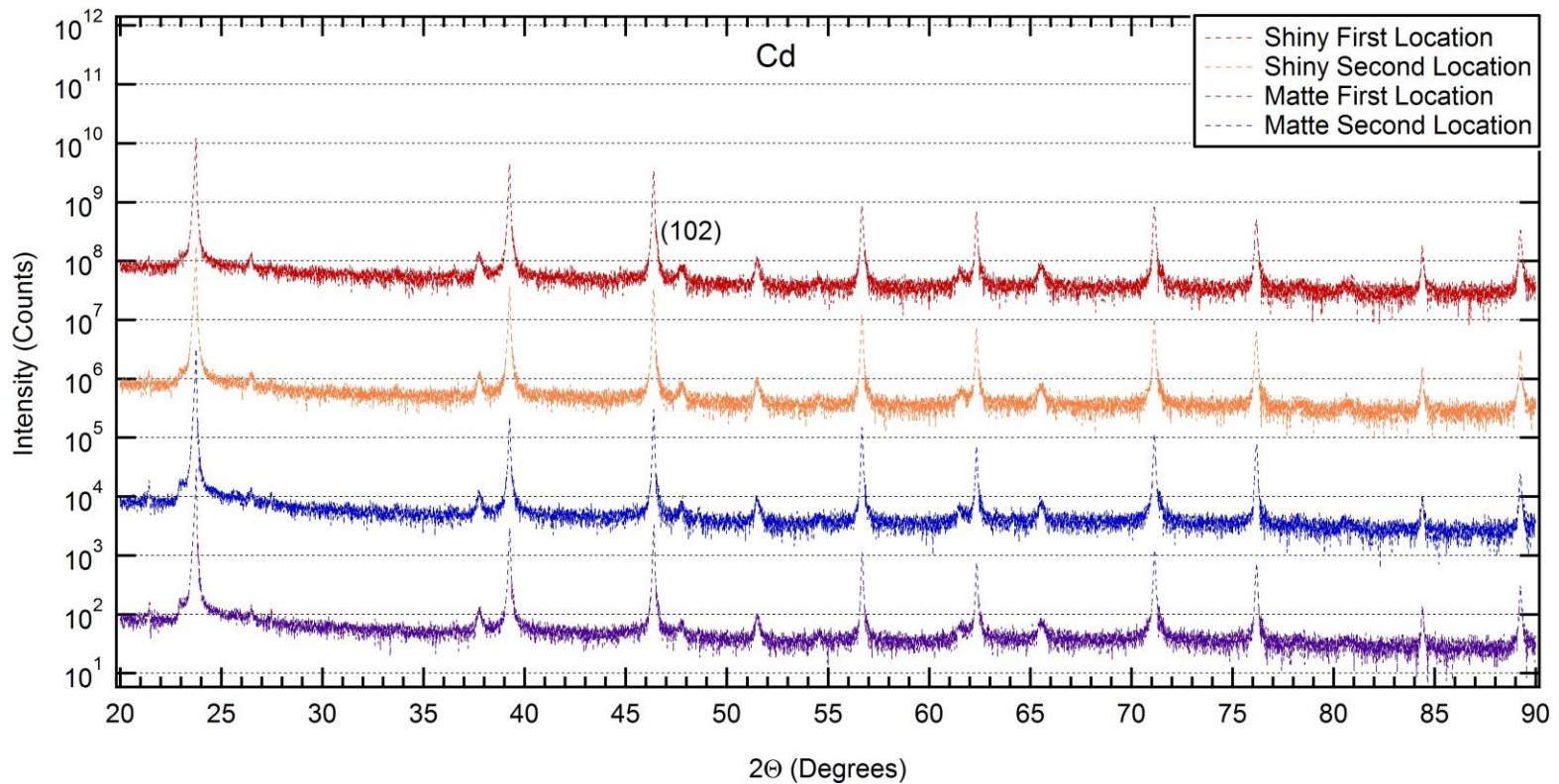
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Raw Data



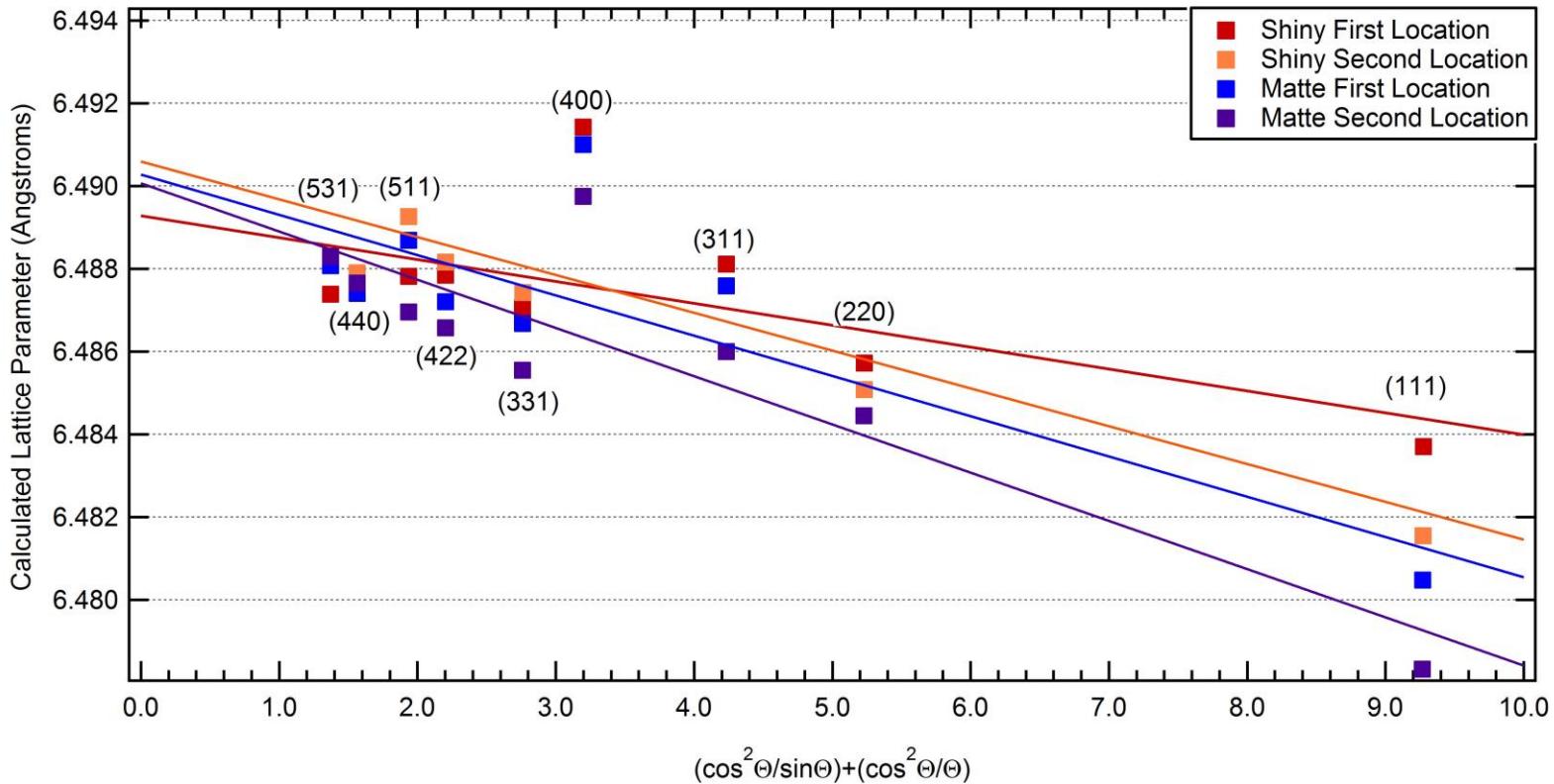
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Raw Data



Peaks were considered if they were known CdTe peaks. Peaks from other layers (ex. CdS) were not included.

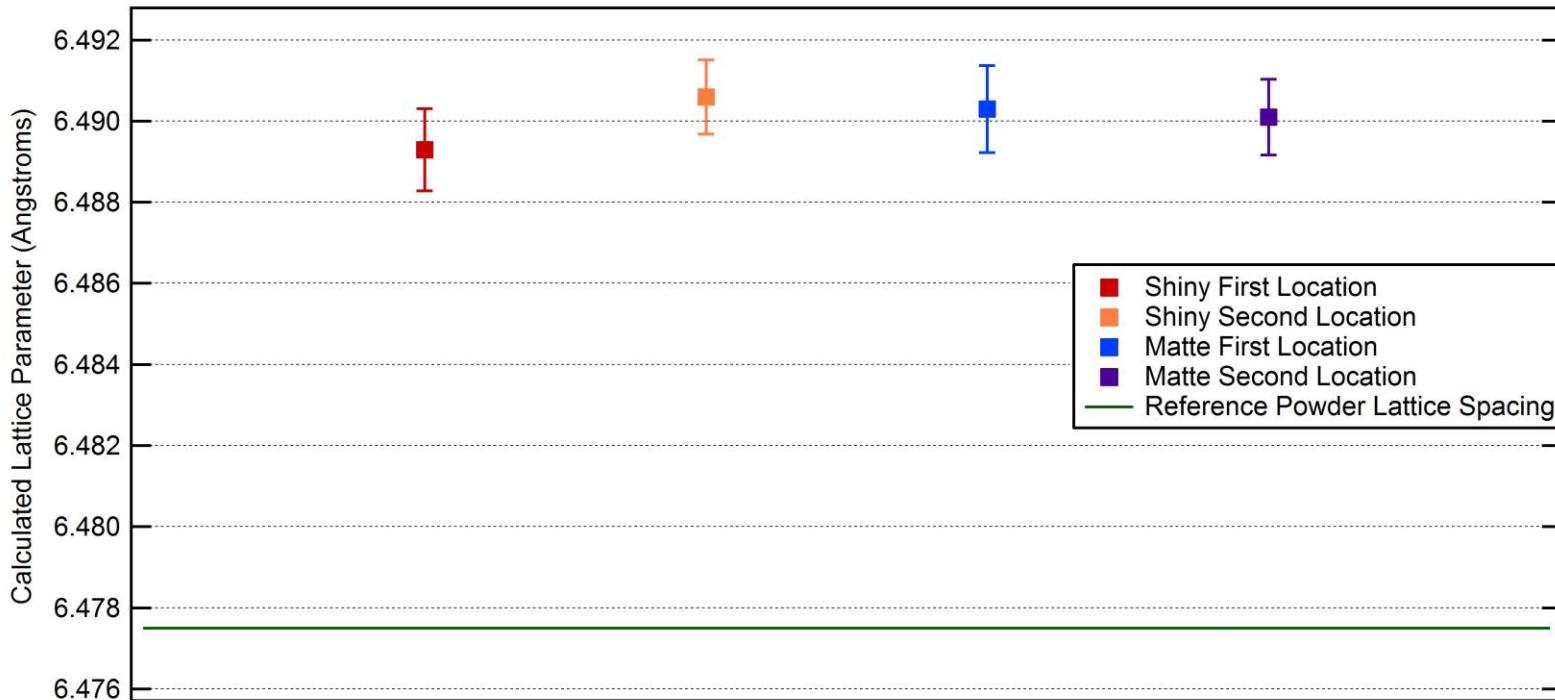
Calculated Lattice Parameter



Data points calculated using:

$$a = \frac{\lambda \sqrt{h^2 + k^2 + l^2}}{2 \sin \theta}$$

Lattice Parameter



Orientation factor calculated using:

$$p = \frac{I}{\Sigma I} \times \frac{\Sigma I'}{I'}$$

Grain size calculated using:

$$\tau = \frac{K\lambda}{\beta \cos\theta}$$

	Shiny First Location	Shiny Second Location	Matte First Location	Matte Second Location
Orientation Factor p for (111) Orientation	1.32	1.60	2.00	1.90
Average Grain size τ (nanometers)	264.86	302.70	302.70	325.99
Lattice Parameter a (angstroms)	6.4893 ± 0.0010	6.4906 ± 0.0009	6.4903 ± 0.0011	6.4901 ± 0.0009